

ICS8432-111

700MHz/350MHz

DIFFERENTIAL-TO-3.3V LVPECL FREQUENCY SYNTHESIZER

GENERAL DESCRIPTION



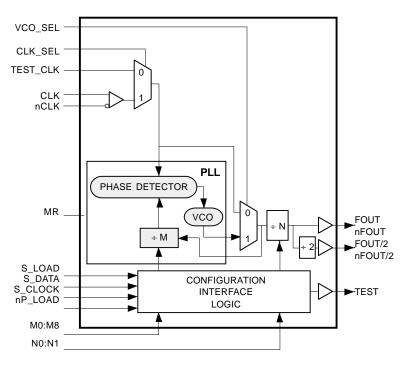
The ICS8432-111 is a general purpose, dual output Differential-to-3.3V LVPECL High Frequency Synthesizer and a member of the HiPerClockS™ family of High Performance Clocks Solutions from ICS. The VCO operates at a frequency range of

250MHz to 700MHz. The VCO frequency is programmed in steps equal to the value of the input differential or single ended reference frequency. Output frequencies up to 700MHz for FOUT and 350MHz for FOUT/2 can be programmed using the serial or parallel interfaces to the configuration logic. The low phase noise characteristics and the multiple frequency outputs of the ICS8432-111 makes it an ideal clock source for Fiber Channel 1 and 2, and Infiniband applications.

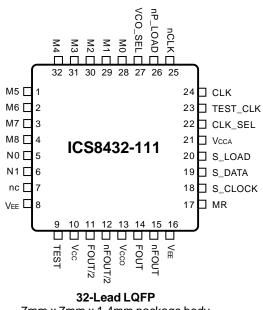
FEATURES

- FOUT and FOUT/2 differential 3.3V LVPECL outputs
- Selectable CLK, nCLK pair and LVCMOS reference inputs
- CLK, nCLK pair can accept the following differential input levels: LVPECL, LVHSTL, LVDS, SSTL, HCSL
- Maximum FOUT frequency up to 700MHz Maximum FOUT/2 frequency up to 350MHz
- 14MHz to 25MHz differential input or reference input frequency
- VCO range: 250MHz 700MHz
- Parallel or serial interface for programming counter and VCO frequency multiplier and dividers
- 3.3V supply voltage
- 0°C to 70°C ambient operating temperature

BLOCK DIAGRAM



PIN ASSIGNMENT



32-Lead LQFP
7mm x 7mm x 1.4mm package body
Y Package
Top View

The Preliminary Information presented herein represents a product in prototyping or pre-production. The noted characteristics are based on initial product characterization. Integrated Circuit Systems, Incorporated (ICS) reserves the right to change any circuitry or specifications without notice.



ICS8432-111

700MHz/350MHz

DIFFERENTIAL-TO-3.3V LVPECL Frequency Synthesizer

FUNCTIONAL DESCRIPTION

NOTE: The functional description that follows describes operation using a 25MHz clock input. Valid PLL loop divider values for different input frequencies are defined in the Input Frequency Characteristics, Table 5, NOTE 1.

The ICS8432-111 features a fully integrated PLL and therefore requires no external component for setting the loop bandwidth. A differential clock input is used as the input to the ICS8432-111. This input is fed into the phase detector. A 25MHz clock input provides a 25MHz phase detector reference frequency. The VCO of the PLL operates over a range of 250MHz to 700MHz. The output of the loop divider is also applied to the phase detector.

The phase detector and the loop filter divider force the VCO output frequency to be M times the reference frequency by adjusting the VCO control voltage. Note that for some values of M (either too high or too low) the PLL will not achieve lock. The output of the VCO is scaled by a divider prior to being sent to each of the LVPECL output buffers. The divider provides a 50% output duty cycle.

The programmable features of the ICS8432-111 support two input modes and programmable PLL loop divider and output divider. The two input operational modes are parallel and serial. *Figure 1* shows the timing diagram for each mode. In parallel mode the nP_LOAD input is initially LOW. The data on inputs M0 through M8 and N0 and N1 is passed directly to the ripple counter. On the LOW-to-HIGH transition of the nP_LOAD input the data is latched and the ripple counter remains loaded until the next LOW transition on nP_LOAD or until a serial event occurs. As a result the M and N bits can be hardwired to set the ripple counter to a specific default state that will automatically occur during power-up. The TEST output is LOW when operating in the parallel input mode. The relationship between the VCO frequency, the input frequency and the loop divider is defined as follows:

$$fVCO = f_{IN} \times M$$

The M count and the required values of M0 through M8 are shown in Table 3B, Programmable VCO Frequency Function. Valid M values for which the PLL will achieve lock are defined as $10 \le M \le 28$. The frequency out is defined as follows:

$$fOUT = \frac{fVCO}{N} = f_{IN} \times \frac{M}{N}$$

Serial operation occurs when nP_LOAD is HIGH and S_LOAD is LOW. The shift register is loaded by sampling the S_DATA bits with the rising edge of S_CLOCK. The contents of the shift register are loaded into the ripple counter when S_LOAD transitions from LOW-to-HIGH. The ripple counter divide values are latched on the HIGH-to-LOW transition of S_LOAD. If S_LOAD is held HIGH data at the S_DATA input is passed directly to the ripple counter on each rising edge of S_CLOCK. The serial mode can be used to program the M and N bits and test bits T1 and T0. The internal registers T0 and T1 determine the state of the TEST output as follows:

<u>T1</u>	<u>T0</u>	<u>TEST Output</u>
0	0	LOW
0	1	S_Data
1	0	Output of M divider
1	1	CMOS Fout/2

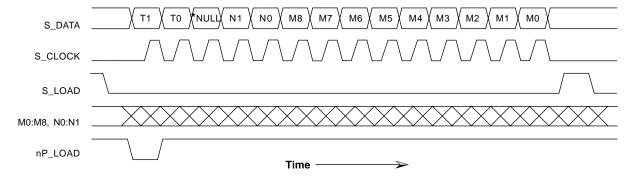


FIGURE 1. PARALLEL & SERIAL LOAD OPERATIONS

*NOTE: The NULL timing slot must be observed.



ICS8432-111

700MHz/350MHz

DIFFERENTIAL-TO-3.3V LVPECL FREQUENCY SYNTHESIZER

TABLE 1. PIN DESCRIPTIONS

Number	Name	Ту	/pe	Description
1	M5	Input	Pullup	
2, 3, 4, 28, 29, 30, 31, 32	M6, M7, M8, M0, M1, M2, M3, M4	Input	Pulldown	M counter/divider inputs. Data latched on LOW-to-HIGH transistion of nP_LOAD input. LVCMOS / LVTTL interface levels.
5, 6	N0, N1	Input	Pulldown	Determines output divider value as defined in Table 3C Function table. LVCMOS / LVTTL interface levels.
7	nc	Unused		No connect
8, 16	V_{EE}	Power		Negative supply pins. Connect to ground.
9	TEST	Output		Test output which is ACTIVE in the serial mode of operation. Output driven LOW in parallel mode. LVCMOS interface levels.
10	V _{cc}	Power		Positive supply pin.
11, 12	FOUT/2, nFOUT/2	Output		Half frequency differential output for the synthesizer. 3.3V LVPECL interface levels.
13	V _{cco}	Power		Output supply pin. Connect to 3.3V.
14, 15	FOUT, nFOUT	Output		Differential output for the synthesizer. 3.3V LVPECL interface levels.
17	MR	Input	Pulldown	Forces outputs LOW, but does not effect loaded M, N, and T values. LVCMOS / LVTTL interface levels.
18	S_CLOCK	Input	Pulldown	Clocks in serial data present at S_DATA input into the shift register on the rising edge of S_CLK.
19	S_DATA	Input	Pulldown	Shift register serial input. Data sampled on the rising edge of S_CLK.
20	S_LOAD	Input	Pulldown	Controls transition of data from shift register into the ripple counter. LVCMOS / LVTTL interface levels.
21	V _{CCA}	Power		Analog supply pin. Connect to 3.3V.
22	CLK_SEL	Input	Pullup	Selects between differential clock input or test input as the PLL reference source. LVCMOS / LVTTL interface levels. Selects CLK, nCLK inputs when HIGH. Selects TEST_CLK when LOW.
23	TEST_CLK	Input	Pulldown	Test clock input. LVCMOS / LVTTL interface levels.
24	CLK	Input	Pulldown	Non-inverting differential clock input.
25	nCLK	Input	Pullup	Inverting differential clock input.
26	nP_LOAD	Input	Pulldown	Parallel load input. Determines when data present at M8:M0 is loaded into ripple counter, and when data present at N1:N0 sets the output divide value. LVCMOS / LVTTL interface levels.
27	VCO_SEL	Input	Pullup	Determines whether synthesizer is in PLL or bypass mode. LVCMOS / LVTTL interface levels.

NOTE: Pullup and Pulldown refers to internal input resistors. See Table 2, Pin Characteristics, for typical values.

TABLE 2. PIN CHARACTERISTICS

Symbol	Parameter		Test Conditions	Minimum	Typical	Maximum	Units
		TEST_CLK, CLK, nCLK				4	pF
C _{IN}	Input Capacitance	M0:M8, N0:N1, MR, S_LOAD, S_DATA, nP_LOAD, S_CLOCK, VCO_SEL, CLK_SEL				4	pF
R _{PULLUP}	Input Pullup Resistor				51		ΚΩ
R _{PULLDOWN}	Input Pulldown Res	istor			51		ΚΩ



ICS8432-111

700MHz/350MHz

DIFFERENTIAL-TO-3.3V LVPECL FREQUENCY SYNTHESIZER

TABLE 3A. PARALLEL AND SERIAL MODES FUNCTION TABLE

			lnı	puts			Conditions
MR	nP_LOAD	М	N	S_LOAD	S_CLOCK	S_DATA	Conditions
Н	Х	Х	Χ	Х	Х	Х	Reset. M and N counters reset.
L	L	Data	Data	Х	Х	Х	Data on M and N inputs passed directly to the ripple counter and output divider. TEST output forced LOW.
L	1	Data	Data	L	Х	Х	Data is latched into input registers and remains loaded until next LOW transition or until a serial event occurs.
L	Н	Х	Х	L	↑	Data	Serial input mode. Shift register is loaded with data on S_DATA on each rising edge of S_CLOCK.
L	Н	Х	Х	1	L	Data	Contents of the shift register are passed to the ripple counter and output divider.
L	Н	Х	Х	\	L	Data	Ripple counter and output divide values are latched.
L	Н	Χ	Х	Ĺ	X	Х	Parallel or serial input do not affect shift registers.

TABLE 3B. PROGRAMMABLE VCO FREQUENCY FUNCTION TABLE

VCO Frequency	M Count	256	128	64	32	16	8	4	2	1
(MHz)	W Count	M8	M7	М6	M5	M4	М3	M2	M1	МО
250	10	0	0	0	0	0	1	0	1	0
275	11	0	0	0	0	0	1	0	1	1
300	12	0	0	0	0	0	1	1	0	0
325	13	0	0	0	0	0	1	1	0	1
•	•	•	•	•	•	•	•	•	•	•
•	•	•	•	•	•	•	•	•	•	•
650	26	0	0	0	0	1	1	0	1	0
675	27	0	0	0	0	1	1	0	1	1
700	28	0	0	0	0	1	1	1	0	0

NOTE 1: These M count values and the resulting frequency correspond to differential input or test clock input frequency of 25MHz.

TABLE 3C. PROGRAMMABLE OUTPUT DIVIDER FUNCTION TABLE

Inputs		N Divider	Output Frequency (MHz)					
-		Value	FC	UT	FOL	JT/2		
N1	N0		Minimum	Maximum	Minimum	Maximum		
0	0	1	250	700	125	350		
0	1	2	125	350	62.5	175		
1	0	4	62.5	175	31.25	87.5		
1	1	8	31.25	87.5	15.625	43.75		



ICS8432-111

700MHz/350MHz

DIFFERENTIAL-TO-3.3V LVPECL FREQUENCY SYNTHESIZER

ABSOLUTE MAXIMUM RATINGS

Supply Voltage, V_{CCx} 4.6V

Inputs, V, -0.5V to V_{cc} + 0.5V -0.5V to V_{cc} + 0.5V Outputs, Vo

Package Thermal Impedance, $\boldsymbol{\theta}_{JA}$ 47.9°C/W Storage Temperature, T_{STG} -65°C to 150°C

Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These ratings are stress specifications only. Functional operation of product at these condition or any conditions beyond those listed in the DC Characteristics or AC Characteristics is not implied. Exposure to absolute maximum rating conditions for extended periods may affect product reliability.

Table 4A. Power Supply DC Characteristics, $V_{CC} = V_{CCA} = V_{CCO} = 3.3V \pm 5\%$, Ta = 0°C to 70°C

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
V _{cc}	Positive Supply Voltage		3.135	3.3	3.465	V
V _{CCA}	Analog Supply Voltage		3.135	3.3	3.465	V
V _{cco}	Output Supply Voltage		3.135	3.3	3.465	V
I _{EE}	Power Supply Current				110	mA

Table 4B. LVCMOS / LVTTL DC Characteristics, $V_{CC} = V_{CCA} = V_{CCO} = 3.3V \pm 5\%$, Ta = 0°C to 70°C

Symbol	Parameter		Test Conditions	Minimum	Typical	Maximum	Units
V _{IH}	Input High Voltage	VCO_SEL, XTAL_SEL, S_LOAD, S_DATA, S_CLOCK, nP_LOAD, N0:N1, M0:M8, MR	V _{cc} = 3.465V	2		3.765	٧
		TEST_CLK	V _{CC} = 3.465V	1.7		3.765	٧
V _{IL}	Input Low Voltage	VCO_SEL, XTAL_SEL, S_LOAD, S_DATA, S_CLOCK, nP_LOAD, N0:N1, M0:M8, MR	V _{cc} = 3.135V	-0.3		0.8	V
		TEST_CLK	V _{cc} = 3.135V		3.765 V 3.765 V 0.8 V 1.3 V 150 µ/	V	
I _{IH}	Input High Current	M0-M4, M6-M8, N0, N1, S_CLOCK, S_DATA, S_LOAD, TEST_CLK, nP_LOAD, MR	*V _{CCx} = V _{IN} = 3.465V			150	μΑ
		$ \begin{array}{c} \text{s.t.} \\ \text{h. Voltage} \\ \text{h. Voltage} \\ \\ \text{No:N1, Mo:M8, MR} \\ \\ \hline \\ \text{TEST_CLK} \\ \\ \text{VCO_SEL, XTAL_SEL, S_LOAD,} \\ \text{S_DATA, S_CLOCK, nP_LOAD,} \\ \text{Voltage} \\ \\ \text{Voltage} \\ \\ \hline \\ \text{Voltage} \\ \\ \hline \\ \text{Voltage} \\ \\ \\ \text{Voltage} \\ \\ \hline \\ \text{Voltage} \\ \\ \\ \text{Voltage} \\ \\ \hline \\ \text{Voltage} \\ \\ \\ \\ \text{Voltage} \\ \\ \hline \\ \text{Voltage} \\ \\ \\ \\ \\ \text{Voltage} \\ \\ \\ \\ \\ \\ \text{Voltage} \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\$	μΑ				
I _{IL}	Input Low Current	S_CLOCK, S_DATA, S_LOAD,		-5			μΑ
	Low Garrent	M5, XTAL_SEL, VCO_SEL		-150			μA
V _{OH}	Output High Voltage	TEST		2.6			V
V _{OL}	Output Low Voltage	TEST	$^{*}V_{CCx} = 3.135V,$ $I_{OL} = 36mA$			0.5	>

*NOTE: V_{CCx} denotes V_{CC} , V_{CCA} , and V_{CCO} .

8432BY-111



ICS8432-111

700MHz/350MHz

DIFFERENTIAL-TO-3.3V LVPECL FREQUENCY SYNTHESIZER

Table 4C. Differential DC Characteristics, $V_{CC} = V_{CCA} = V_{CCO} = 3.3V \pm 5\%$, Ta = 0°C to 70°C

Symbol	Parameter		Test Conditions	Minimum	Typical	Maximum	Units
	Input High Current	CLK	V _{IN} = 3.465V			150	μΑ
¹ _{IH}	Imput High Current	nCLK	$V_{IN} = 3.465V$			5	μA
	Input Low Current	CLK	$V_{IN} = 0V$	-5			μA
I _{IL}	Input Low Current	nCLK	$V_{IN} = 0V$	-150			μA
V _{PP}	Peak-to-Peak Input	Voltage		0.15		1.3	V
V _{CMR}	Common Mode Inp NOTE 1, 2	ut Voltage;		0.13		1.3	V

NOTE 1: Common mode voltage is defined as V_H . NOTE 2: For single ended applications the maximum input voltage for CLK and nCLK is V_{CC} + 0.3V.

Table 4D. LVPECL DC Characteristics, $V_{\text{CC}} = V_{\text{CCA}} = V_{\text{CCO}} = 3.3 \text{V} \pm 5\%$, Ta = 0°C to 70°C

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
V _{OH}	Output High Voltage; NOTE 1		V _{cco} - 1.4		V _{cco} - 1.0	V
V _{OL}	Output Low Voltage; NOTE 1		V _{cco} - 2.0		V _{cco} - 1.7	V
V_{SWING}	Peak-to-Peak Output Voltage Swing		0.6		0.85	V

NOTE 1: Outputs terminated with 50 Ω to V_{CCO} - 2V.



ICS8432-111

700MHz/350MHz

DIFFERENTIAL-TO-3.3V LVPECL FREQUENCY SYNTHESIZER

Table 5. Input Frequency Characteristics, $V_{cc} = V_{cca} = V_{cco} = 3.3V \pm 5\%$, Ta = 0°C to 70°C

Symbol	Parameter		Test Conditions	Minimum	Typical	Maximum	Units
f _{IN}		TEST_CLK; NOTE 1		14		25	MHz
	Maximum Input Frequency	CLK, nCLK; NOTE 1		14		25	MHz
		S_CLOCK				TBD	MHz

NOTE 1: For the differential input and test clock input frequency range the M value must be set for the VCO to operate within the 250MHz to 700MHz range. Using the minimum input frequency of 14MHz valid values of M are $18 \le M \le 50$. Using the maximum frequency of 25MHz valid values of M are $10 \le M \le 28$.

Table 6. AC Characteristics, $V_{CC} = V_{CCA} = V_{CCO} = 3.3V \pm 5\%$, Ta = 0°C to 70°C

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
FOUT	Maximum Output Frequency		31.25		700	MHz
tjit(acc)	Accumulative Period Jitter, RMS; NOTE 1, 3					ps
tjit(per)	Period Jitter, RMS; NOTE 1, 3					ps
tsk(o)	Output Skew; NOTE 2, 3					ps
odc	Output Duty Cycle		47		53	%
t _R	Output Rise Time	20% to 80%	300		800	ps
t _F	Output Fall Time	20% to 80%	300		800	ps
t _s	Setup Time		TBD			ns
t _H	Hold Time		TBD			ns
t _{LOCK}	PLL Lock Time				TBD	ms
t _{PW}	Pulse Width				TBD	ns

All parameters measured at 500MHz unless noted otherwise.

NOTE 1: Jitter performance using TEST_CLK input.

NOTE 2: Defined as skew between outputs at the same supply voltage and with equal load conditions.

Measured at the output differential cross points.

NOTE 3: This parameter is defined in accordance with JEDEC Standard 65.

ICS8432-111

700MHz/350MHz

DIFFERENTIAL-TO-3.3V LVPECL FREQUENCY SYNTHESIZER

PACKAGE OUTLINE - Y SUFFIX

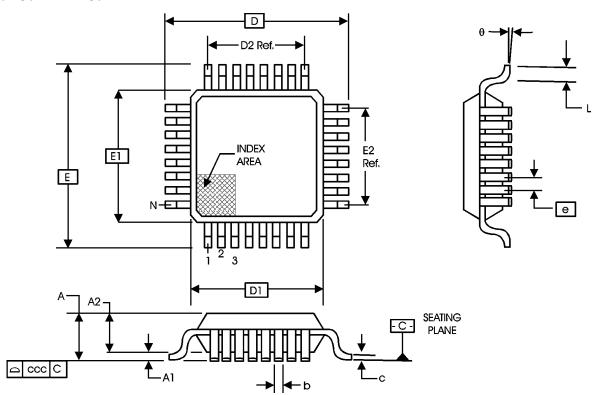


TABLE 7. PACKAGE DIMENSIONS

JEDEC VARIATION ALL DIMENSIONS IN MILLIMETERS					
SYMBOL	ВВА				
	MINIMUM	NOMINAL	MAXIMUM		
N	32				
Α			1.60		
A1	0.05		0.15		
A2	1.35	1.40	1.45		
b	0.30	0.37	0.45		
С	0.09		0.20		
D	9.00 BASIC				
D1	7.00 BASIC				
D2	5.60 Ref.				
E	9.00 BASIC				
E1	7.00 BASIC				
E2	5.60 Ref.				
е	0.80 BASIC				
L	0.45	0.60	0.75		
θ	0°		7°		
ccc			0.10		

Reference Document: JEDEC Publication 95, MS-026



ICS8432-111 700MHz/350MHz

DIFFERENTIAL-TO-3.3V LVPECL FREQUENCY SYNTHESIZER

TABLE 8. ORDERING INFORMATION

Part/Order Number	Marking	Package	Count	Temperature
ICS8432AY-111	ICS8432AY-111	32 Lead LQFP	250 per tray	0°C to 70°C
ICS8432AY-111T	ICS8432AY-111	32 Lead LQFP on Tape and Reel	1000	0°C to 70°C

While the information presented herein has been checked for both accuracy and reliability, Integrated Circuit Systems, Incorporated (ICS) assumes no responsibility for either its use or for infringement of any patents or other rights of third parties, which would result from its use. No other circuits, patents, or licenses are implied. This product is intended for use in normal commercial applications. Any other applications such as those requiring extended temperature range, high reliability, or other extraordinary environmental requirements are not recommended without additional processing by ICS. ICS reserves the right to change any circuitry or specifications without notice. ICS does not authorize or warrant any ICS product for use in life support devices or critical medical instruments.